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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
10/664,299	09/17/2003	David William Trepess	282530US8X	4575

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OBLON, SPIVAK, MCCLELLAND MAIER & NEUSTADT, L.L.P.  
1940 DUKE STREET  
ALEXANDRIA, VA 22314

EXAMINER
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LONG, ANDREA NATAE

ART UNIT	PAPER NUMBER
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2175

NOTIFICATION DATE	DELIVERY MODE
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11/03/2009

ELECTRONIC

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10664299	9/17/2003	TREPESS ET AL.	282530US8X

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**EXAMINER**

Andrea N. Long

ART UNIT	PAPER
2175	20091027

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**Commissioner for Patents**

In regard to Application 10/664299,

The prior art referenced as AO (2002-041571) on the IDS submitted 07/15/2009 has been considered. The Examiner's determination of relevancy is based solely on what is found in the Japanese Office Action with an English translation citing this document and its relevancy submitted by the Applicant.

/William L. Bashore/  
Supervisory Patent Examiner, Art Unit 2175